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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
10/033,891	01/03/2002	Yeong-Song Yen	148693.00403	9634		
7590 03/17/2004			EXAM	EXAMINER		
Thomas T. Moga			KIM, PETER B			
Dickinson Wri 1901 L Street,		ART UNIT	PAPER NUMBER			
Suite 800		2851 DATE MAILED: 03/17/2004				
Washington, I	DC 20036					

Please find below and/or attached an Office communication concerning this application or proceeding.

		Applicati	on No	Applicant(s)				
Office Action Summary		10/033,89		YEN ET AL.				
		Examine		Art Unit	T			
		Peter B.		2851				
	The MAILING DATE of this communication ap				ddress			
Period for Reply								
THE - Exte after - If the - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR REPI MAILING DATE OF THIS COMMUNICATION resions of time may be available under the provisions of 37 CFR 1 SIX (6) MONTHS from the mailing date of this communication. Period for reply specified above is less than thirty (30) days, a replayer of the provision of the p	.136(a). In no ev ply within the stat I will apply and w te, cause the app	ent, however, may a reply be time utory minimum of thirty (30) days ill expire SIX (6) MONTHS from lication to become ABANDONE	nely filed s will be considered time the mailing date of this of				
Status								
1)⊠	1) Responsive to communication(s) filed on 02 February 2004.							
2a)⊠	This action is FINAL . 2b) This action is non-final.							
3)	3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is							
	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.							
Disposition of Claims								
4)🖂)⊠ Claim(s) <u>1-29</u> is/are pending in the application.							
	4a) Of the above claim(s) is/are withdrawn from consideration.							
5)[S) ☐ Claim(s) is/are allowed. E) ☐ Claim(s) 1-29 is/are rejected. Claim(s) is/are objected to.							
6)⊠								
·								
8)	Claim(s) are subject to restriction and/	or election r	equirement.					
Applicati	on Papers							
9)[The specification is objected to by the Examin	er.						
10)	10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.							
	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).								
11)	The oath or declaration is objected to by the E	xaminer. No	ote the attached Office	Action or form P	TO-152.			
Priority ι	ınder 35 U.S.C. § 119							
12)	Acknowledgment is made of a claim for foreig	n priority un	der 35 U.S.C. § 119(a)	-(d) or (f).				
a) ☐ All b) ☐ Some * c) ☐ None of:								
	1. Certified copies of the priority documents have been received.							
	2. Certified copies of the priority documents have been received in Application No							
3. Copies of the certified copies of the priority documents have been received in this National Stage								
	application from the International Burea	•	• • • •					
* See the attached detailed Office action for a list of the certified copies not received.								
Aug	Ma)							
Attachmen	t(s) e of References Cited (PTO-892)		4) Interview Summary	(PTO_413)				
2) Notic	e of Draftsperson's Patent Drawing Review (PTO-948)		Paper No(s)/Mail Da	ite				
3) Infor	mation Disclosure Statement(s) (PTO-1449 or PTO/SB/08 r No(s)/Mail Date	3)	5) Notice of Informal P 6) Other:	atent Application (PT	O-152)			

DETAILED ACTION

Applicant's arguments filed on Feb. 2, 2004 have been fully considered.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-29 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hirukawa (2003/0103196) in view of Hirukawa et al. (5,703,675).

Hirukawa discloses in para 0100 – 0138, a photolithography process with multiple exposures comprising, providing a wafer (W) having a photoresist formed thereon, providing photomasks (R) with dense and isolated patterns aligned above the wafer; sequentially performing multiple exposures with a respective illumination setting optimized for one duty ratio for dense and isolated patterns by performing a first exposure through the isolated pattern and the second exposure through the dense pattern, and performing a development on the photoresist (para 0135-0138). Hirukawa discloses the multiple exposures performed by an exposure tool (Fig. 1) and with respect to each exposure the illumination setting includes numerical aperture, sigma value, focus, pupil type and exposure energy wherein the exposure are performed with an illuminating wavelength selected from I-line, deep UV ray, EUV ray, X-ray and ion projection lithography (para 0106-0110). However, Hirukawa (2003/0103196) does not disclose a photomask with a dense pattern and an isolated pattern. Hirukawa et al. (5,703,675) discloses in col. 41, line 18-35, projection exposure apparatus with a mask with both dense and isolated

pattern. Hirukawa also discloses sigma value less than 0.35 in col. 41, lines 36-45. Therefore, it would have been obvious to one of ordinary skill in the art at the time of invention to provide the photomask of Hirukawa et al. to the invention of Hirukawa because it is a matter of routine to combine two separate articles into one, and once the structures are combined, the method as Hirukawa can be used to expose the wafer.

Response to Arguments

Applicant argues that Hirukawa (2003/0103196) does not teach one photomask with a dense pattern and an isolated pattern. However, it would have been obvious to replace the two masks with one mask with a dense pattern and an isolated pattern. It would be obvious to one of ordinary skill in the art to provide a single mask with both of the patterns shown in Fig. 2A and 2B of Hirukawa because it would be obvious to combine two separate articles into one. Hirukawa et al. (5,703,675) teaches a photomask with both dense and isolated patterns.

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event,

Application/Control Number: 10/033,891 Page 4

Art Unit: 2851

however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Peter Kim whose telephone number is (571) 272-2120. The examiner can normally be reached on Monday-Thursday from 8:30 AM to 6:00 PM. The examiner can also be reached on alternate Fridays during the same hours.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Russ Adams can be reached on 571-272-2112. The fax phone numbers for the organization where this application or proceeding is assigned is 703 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 571 –272-2800.

Peter B. Kim
Patent Examiner

March 9, 2004